a series

1ST ONLINE HANDS-ON-TRAINING ON RIETVELD REFINEMENT OF X-RAY DIFFRACTION (RRD)

(USING FULLPROF SOFTWARE PACKAGE)

Centre for Advanced Computational Research, New Delhi, India

(Registered under Ministry of SME, Government of India for Research and Experimental Development on Natural Sciences and Engineering) (ISO 9001:2015 Certification for Hands-on-Training on Computational Science including DFT calculation of Materials, Molecular Docking and Dynamics) Website: https://cacrdelhi.com, Email: admin@trainingcacrdelhi.com

|Space Group Determination| |Indexing (h k l)|, |Profile Fitting| |Crystallite Size-Strain Analysis| |Lattice Parameter Calculation| |Williamson-Hall Plot| |Phase Identification| |Theoretical X-ray Diffraction Pattern|

[Online + Recordings] Date: 8th April – 14th April 2025

Timing: Morning Batch: 9:00 AM – 10:00 AM IST or Evening Batch: 9:00 PM – 10:00 PM IST

[Online Live Sessions along with Complete Recordings]

1. About Us

Centre for Advanced Computational Research, New Delhi, India, established in April 2021, is an International Research unit with research focus in Materials Sciences, Analytical chemistry, Organic & Inorganic chemicals synthesis, Pharmaceuticals and Bioinformatics. The R&D activities primarily involve Novel the in-depth spectroscopic studies of material via modern computational chemistry/physics approaches toward their applications in organic lightemitting diodes (OLEDs), Photovoltaics, catalysis, Optoelectronic devices, polymer design, energy-based materials, non-linear optical activity, energy transfer mechanisms, and Bioinformatics. The organization is headed by Dr. Nikhil Aggarwal along with 15 External Faculty Members and 18 project students from the premier research institutions of India and abroad including IISC Bangalore, IITs, NITs, CSIR Labs, etc. We are also actively engaged in promoting Computational Sciences online via Workshops/Hands-on-Training. We are proud to say that we are the first to introduce Hands-on-Training (Online and Onsite) on Quantum Chemical calculation via Density Functional Theory Approach. In a short span of 4 years, we have trained 8000+ Graduate students, Research Scholars, Professors &

Industry Experts from 35 countries including the India, US, UK, Saudi Arabia, Mexico, Brazil, Malaysia, Kuwait, Germany, Peru, South Korea, Finland, Turkey, Iraq, Australia, Philippines, Spain, Jordan, Chile, Taiwan, South Africa, Pakistan, Nepal, Bangladesh, Nigeria, Morocco, Egypt, Sri Lanka and Algeria, Singapore, Columbia, Sweden, Botswana, Belgium, Canada and rated <u>4.78/5.00</u> by 700+ International and National participants of our previous workshops. Centre previously had 5 invited lectures:

- Dr. Snehasis Daschakraborty, Asst. Prof. (IIT Patna):[<u>https://www.youtube.com/watch?v=</u> CaZl0iFJU-I]
- Prof. T. P. Radhakrishnan, Prof. (Hyderabad University):[https://www.youtube.com/watch ?v=5IWNLsntgSU]
- 3. Dr. V. Ramanathan, Asst. Prof. (IIT BHU): [https://www.youtube.com/watch?v=erKb3y 71VN8]
- 4. Prof. Kalidas Sen, Prof. (Emeritus) (Hyderabad University):[https://www.youtube.com/watch ?v=jkz_Hb99vEg]
- 5. **Dr. Ranganathan Subramanian**, Associate Professor (IIT Patna).



Assistant Professor [IIT Patna]

H-Index = 15, Citations = 702

Postdoctoral Research, University of Colorado



Associate Professor, IIT Patna

H-Index = 7, Citations = 550

Ph.D, Wesleyan University

Prof. T. P. Radhakrishnan Professor [University of Hyderabad] H-Index = 38, Citations = 5046 FNASc, FASc, FNA, Ph. D., Princeton University Postdoctoral Research, University of Texas at El Paso



PROF. KALIDAS SEN Professor (Emeritus), Hyderabad University H-Index = 42, Citations = 6024 F.A.Sc., F.N.A.

DR. V. RAMANATHAN Assistant Professor [IIT BHU] H-Index = 11, Citations = 529 Postdoctoral Research, University of Stuttgart, Germany

About FDP/Workshop (Hands-on-Training) Program: 2.

We are glad to announce 7-Days Online FDP/Workshop (Hands-on-Training) program on Rietveld **Refinement of X-Ray Diffraction Data (RRD) (Hands-on-Training using Free Licence Software Tool: FullProf Software package**). There has been a renaissance in powder diffraction in recent years because Rietveld refinement allows determinations of positional and thermal parameters from powder data, even when the diffraction peaks are not well separated in the recorded pattern. In a polycrystalline sample, information may be lost as a result of the random orientation of the crystallites. Rietveld developed a refinement method that uses the profile intensities of the composite peaks instead of the integrated quantities. This is a pattern-fitting method of structure refinement and allows extraction of the maximum amount of information contained in the powder pattern.

- The Hands-on-training Program is planned for **Faculty** (**FDP Completion Certificate**) and **Post-docs**, Research Scholars, post-graduate students (Certification of Training completion).
- \checkmark Training Session is designed as per the guidelines defined by the UGC and can be used for Research Articles publication.
- The required free software's for training will be provided. We understand the Academic schedules of participants so **complete lecture recordings** will be given to all participants.
- 3. Please visit below webpage and submit your Registration Form and Fees

https://www.cacrdelhi.com/event-details/7-days-online-fdp-workshophands-on-training-on-rietveld-refinement-of-x-ray-diffraction-datausing-fullprof-package-2

or

https://www.cacrdelhi.com/rrd-refinement

4. Day wise Schedule

8th April 2025: Day 1 Session 1

- Rietveld Refinement of X-ray Diffraction Data Using FullProf Package
- Rietveld Refinement of X-ray Diffraction Data of **Doped Samples** Using FullProf Package

9th April 2025 Day 2 Session 2

- Rietveld Refinement of X-ray Diffraction Data of NBT Using FullProf Package
- Space Group Determination & Indexing from XRD Data

10th April 2025 Day 3 Session 3

- Instrumental Resolution File (IRF) for Rietveld Refinement Using FullProf Package
- Rietveld Refinement Study of Some Perovskite Type Solid Solutions: Theory and Application

11th April 2025 Day 4 Session 4

Profile Fitting and Crystallite Size-Strain Analysis

12th April 2025 Day 5 Session 5

Lattice Parameter Calculation and Indexing (h k l)

13th April 2025 Day 6 Session 6

- Williamson-Hall Plot from XRD Rietveld Analysis: Crystallite Size and Strain
- Phase Identification Using Rietveld Fit

14th April 2025 Day 7 Session 7

Simulate a Theoretical X-ray Diffraction Pattern from CIF File for Phase Identification

5. <u>Registration Category and Fees</u>

Registration Type	International	National
Faculty or Scientific officer	USD 65	Rs. 2,500
Post-doctorate's Participants	USD 55	Rs. 2,000
Research Scholars and other Participants	USD 45	Rs. 1,500
Undergraduate or Postgraduate	USD 35	Rs. 1,000

6. <u>Salient Features</u>

- ✓ Eligibility: Candidate must have knowledge of undergraduate level science.
- ✓ Hands-on-Training sessions will be taken via online mode: ZOOM, Lecture Mode: English
- ✓ e-certificates will be provided to all registered participants (**minimum 2/7 attendance**)
- ✓ Training will be provided on Windows Operating system
- ✓ Programming and coding knowledge is **not required** for above Hands-on-Training.

Contact at:

admin@trainingcacrdelhi.com, nikhilaggarwal@alumni.iitm.ac.in +91 9790969349 via call or WhatsApp message for any query.

Certificate (Copy) to be issued.

1st Online Handson-Training on

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<u>Certificate of FDP Completion</u>

This is to certify that

<u>UtkarshVerma, Professor, India</u>

has actively participated in the 1st Faculty Development Program (FDP) on Rietveld Refinement of X-Ray Diffraction (RRD) organized by the Centre for Advanced Computational Research, Delhi from 8th – 14th April 2025 via Online Mode. FDP had 7 Interactive Sessions by DR. NIKHIL AGGARWAL on Rietveld Refinement of X-Ray Diffraction data using FullProf

Software Package.



Dr. Nikhil Aggarwal Head of the Department & Convener





ISO Accreditation Body United Ackreditering Services Limited, United Kingdom Certificate No.: 2025/RRD/F/1/1

1st Online Handson-Training on RIETVELD REFINEMENT OF XRAY DIFFRACTION & RD) (using FullProf Software Package)

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Software Package.

ISO 9001:2015

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